

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the application of:

Kazutoshi OHMORI et al.

Appln. No.:

Filed: HEREWITH

For: SEMICONDUCTOR DEVICE AND MANUFACTURING METHOD THEREOF

* * *

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

Pursuant to 37 C.F.R. § 1.56, and without any assertion as to materiality or prior art effect, the documents listed on the attached Form PTO-1449 are hereby cited.

Documents AH-AP and BH-BJ on the attached List were cited in the specification, on pages 2-4, and their relevance is indicated therein. Documents AA-AG are U.S. counterparts to Documents AH, AI, AL, AO, AP, BH, and BL, respectively.

Respectfully submitted,

MWS:skj

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October 15, 2003

By: 
Mitchell W. Shapiro
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FORM PTO-1449 LIST OF DOCUMENTS CITED BY APPLICANT				Atty. Docket No. XA-9959	Appn. No.	
				Applicant Kazutohi OHMORI et al.		
				Filing Date HEREWITH	Group	
U.S. PATENT DOCUMENTS						
Examiner Initial	Document Number	Date	Name	Class	Sub-class	Filing Date
AA	6,479,408	11/12/02	Shioya et al.	438	789	
AB	6,340,435	01/22/02	Bjorkman et al.	216	72	
AC	2002/0168849	11/14/02	Lee et al.	438	637	
AD	6,255,217	07/03/01	Agnello et al.	438	687	
AE	2001/0054765	12/27/01	Ohto et al.	257	751	
AF	2002/0192945	12/19/02	Nagahara	438	637	
AG	2003/0030146	02/13/03	Tamaru et al.	257	762	
FOREIGN PATENT DOCUMENTS						
Examiner Initial	Document Number	Date	Country	Class	Sub-class	Translation
AH	2001-326279	11/22/01	Japan			Abstract
AI	2001-110789	04/20/01	Japan			Yes
AJ	2002-203899	07/19/02	Japan			Abstract
AK	2002-134494	05/10/02	Japan			Abstract
AL	2002-353310	12/06/02	Japan			Abstract
AM	2003-142593	05/16/03	Japan			Abstract
AN	2003-152076	05/23/03	Japan			Abstract
AO	2000-200832	07/18/00	Japan			Abstract
AP	2002-9150	01/11/02	Japan			Abstract
OTHER (including author, title, date, pertinent pages, etc.)						
AQ						
AR						
AS						
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U.S. PATENT DOCUMENTS						
Examiner Initial	Document Number	Date	Name	Class	Sub-class	Filing Date
BA						
BB						
BC						
BD						
BE						
BF						
BG						
FOREIGN PATENT DOCUMENTS						
Examiner Initial	Document Number	Date	Country	Class	Sub-class	Translation
BH	2002-373936	12/26/02	Japan			Abstract
BI	2002-170882	06/14/02	Japan			Abstract
BJ	2002-270691	09/20/02	Japan			Abstract
BK	2002-324837	11/08/02	Japan			Abstract
BL	2003-60030	02/28/03	Japan			Abstract
BM						
BN						
BO						
BP						
OTHER (including author, title, date, pertinent pages, etc.)						
BQ						
BR						
BS						
Examiner			Date Considered			
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